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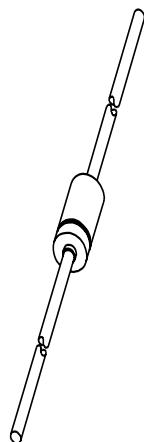
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If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via salesaddresses@nexperia.com). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia

DATA SHEET



BAS45A Low-leakage diode

Product data sheet
Supersedes data of June 1994

1996 Mar 13

Low-leakage diode

BAS45A

FEATURES

- Continuous reverse voltage: max. 125 V
- Repetitive peak forward current: max. 625 mA
- Low reverse current: max. 1 nA
- Switching time: typ. 1.5 μ s.

APPLICATION

- Low leakage current applications.

DESCRIPTION

Epitaxial medium-speed switching diode with a low leakage current in a hermetically-sealed glass SOD68 (DO-34) package.

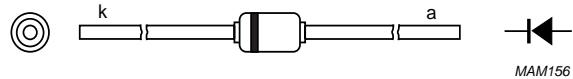


Fig.1 Simplified outline (SOD68; DO-34) and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|-------------------------------------|---|------|------|------|
| V_{RRM} | repetitive peak reverse voltage | | – | 125 | V |
| V_R | continuous reverse voltage | | – | 125 | V |
| I_F | continuous forward current | see Fig.2; note 1 | – | 250 | mA |
| I_{FRM} | repetitive peak forward current | | – | 625 | mA |
| I_{FSM} | non-repetitive peak forward current | square wave; $T_j = 25^\circ\text{C}$ prior to surge; see Fig.4 $t_p = 1 \mu\text{s}$ $t_p = 1 \text{ ms}$ $t_p = 1 \text{ s}$ | – | 4 | A |
| P_{tot} | total power dissipation | $T_{\text{amb}} = 25^\circ\text{C}$ | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +175 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

1. Device mounted on a printed-circuit board without metallization pad.

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ELECTRICAL CHARACTERISTICS

 $T_j = 25^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|----------|-----------------------|---|------------------|----------------------|--|
| V_F | forward voltage | see Fig.3 $I_F = 1 \text{ mA}$ $I_F = 10 \text{ mA}$ $I_F = 100 \text{ mA}$ | — — — | 780 860 1000 | mV mV mV |
| I_R | reverse current | see Fig.5 $V_R = 125 \text{ V}; E_{\text{max}} = 100 \text{ lx}$ $V_R = 30 \text{ V}; T_j = 125^\circ\text{C}; E_{\text{max}} = 100 \text{ lx}$ $V_R = 125 \text{ V}; T_j = 125^\circ\text{C}; E_{\text{max}} = 100 \text{ lx}$ $V_R = 125 \text{ V}; T_j = 150^\circ\text{C}; E_{\text{max}} = 100 \text{ lx}$ | — — — — | 1 300 500 2 | nA nA nA μA |
| C_d | diode capacitance | $f = 1 \text{ MHz}; V_R = 0$; see Fig.6 | — | 4 | pF |
| t_{rr} | reverse recovery time | when switched from $I_F = 10 \text{ mA}$ to $I_R = 10 \text{ mA}; R_L = 100 \Omega$; measured at $I_R = 1 \text{ mA}$; see Fig.7 | 1.5 | — | μs |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|----------------------|---|---------------------------|-------|------|
| $R_{\text{th j-tp}}$ | thermal resistance from junction to tie-point | 8 mm from the body | 300 | K/W |
| $R_{\text{th j-a}}$ | thermal resistance from junction to ambient | lead length 10 mm; note 1 | 500 | K/W |

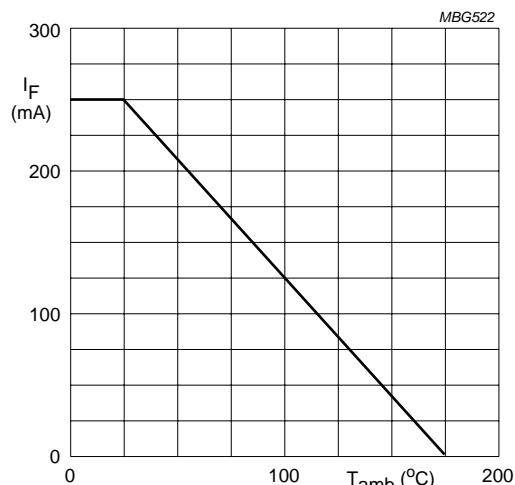
Note

1. Device mounted on a printed-circuit board without metallization pad.

Low-leakage diode

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GRAPHICAL DATA



Device mounted on a printed-circuit board without metallization pad.

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.

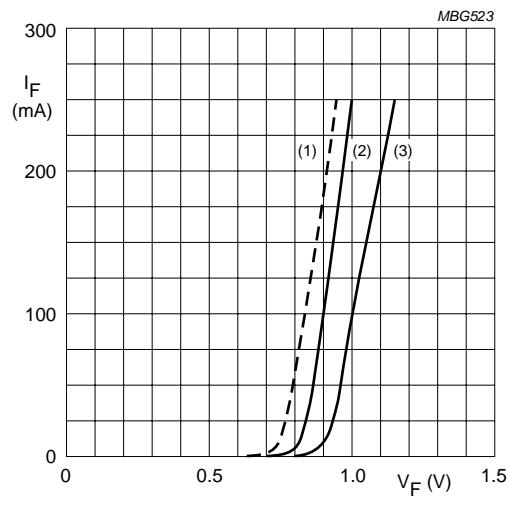
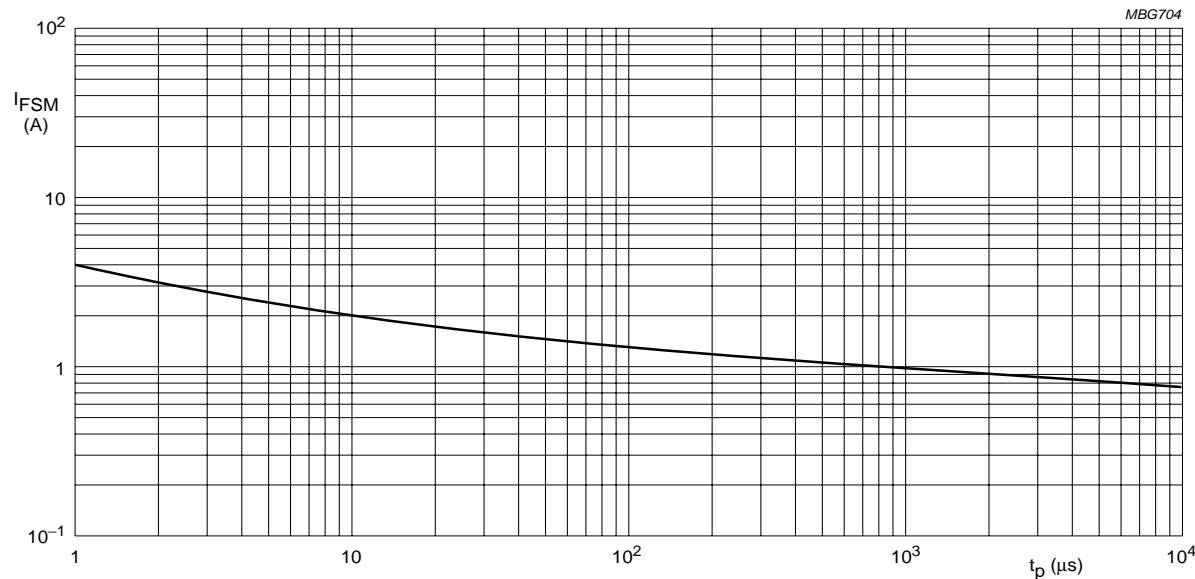


Fig.3 Forward current as a function of forward voltage.



Based on square wave currents; $T_j = 25^{\circ}\text{C}$ prior to surge.

Fig.4 Maximum permissible non-repetitive peak forward current as a function of pulse duration.

Low-leakage diode

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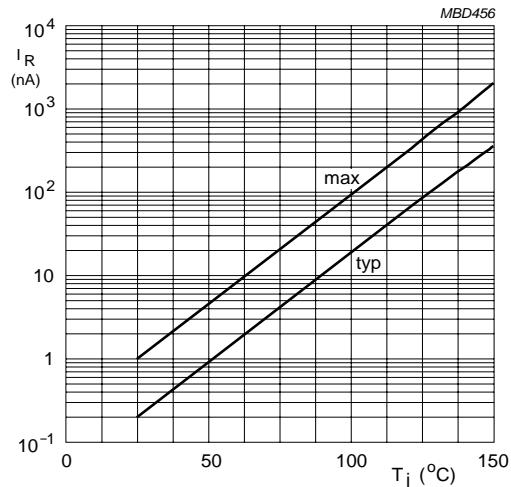
 $V_R = 125$ V.

Fig.5 Reverse current as a function of junction temperature.

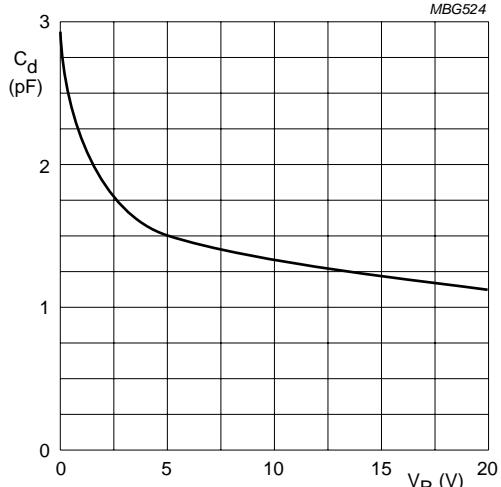
 $f = 1$ MHz; $T_j = 25$ $^{\circ}$ C.

Fig.6 Diode capacitance as a function of reverse voltage; typical values.

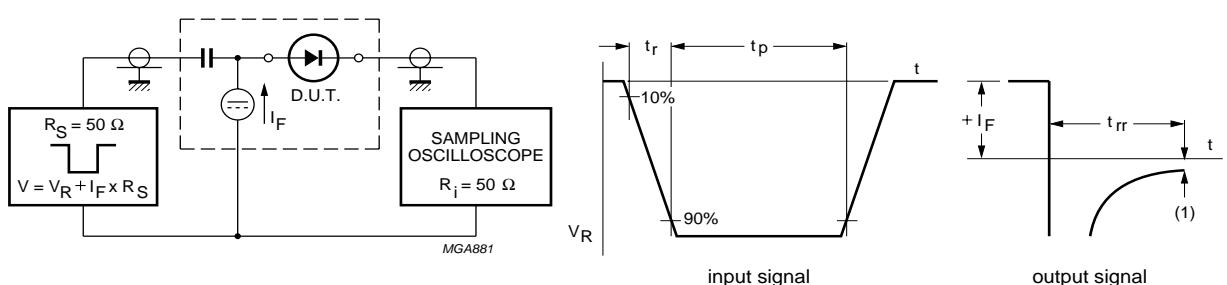
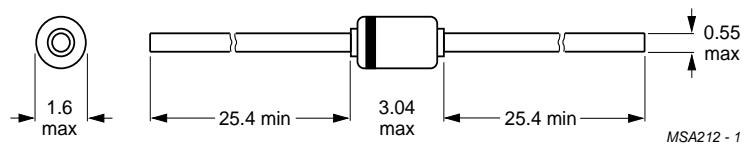


Fig.7 Reverse recovery time test circuit and waveforms.

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PACKAGE OUTLINE



Dimensions in mm.

The black marking band indicates the cathode.

Fig.8 SOD68 (DO-34).

Low-leakage diode**BAS45A****DATA SHEET STATUS**

| DOCUMENT STATUS ⁽¹⁾ | PRODUCT STATUS ⁽²⁾ | DEFINITION |
|--------------------------------|-------------------------------|---|
| Objective data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary data sheet | Qualification | This document contains data from the preliminary specification. |
| Product data sheet | Production | This document contains the product specification. |

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NXP Semiconductors

Customer notification

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Contact information

For additional information please visit: <http://www.nxp.com>

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